

**Search Notes (continued)**

Application/Control No.

09/972,962

Examiner

Anh-Vu H. Ly

Applicant(s)/Patent under  
Reexamination

HAYASHINO ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
interference search history printout		4/29/2006	AVL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR